Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		-
10/567,602	NAKAGAWA ET AL.	NAKAGAWA ET AL.	
Examiner	Art Unit	Art Unit	
TUAN A. PHAM	2618	2618	

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Class	Subclass	Date	Examiner
455	561.1	4/5/2007	PHAM
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INT	NTERFERENCE SEARCHED		
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		SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR				
Consuletd with:	4/7/2007	PHAM				
Nguyen Vo						
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